

Search Notes

Application/Control No.

09/810,241

Examiner

Hieu c. Le

Applicant(s)/Patent under
Reexamination

OHKAWA ET AL.

Art Unit

2142

SEARCHED

Class	Subclass	Date	Examiner
709	238-239	2/10/2006	HL
709	251	2/10/2006	HL
370	216	2/16/2006	HL
714	43	2/16/2006	HL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EASTsearched	2/16/2006	HL
WEST searched	2/17/2006	HL